

## 1.SCOPE

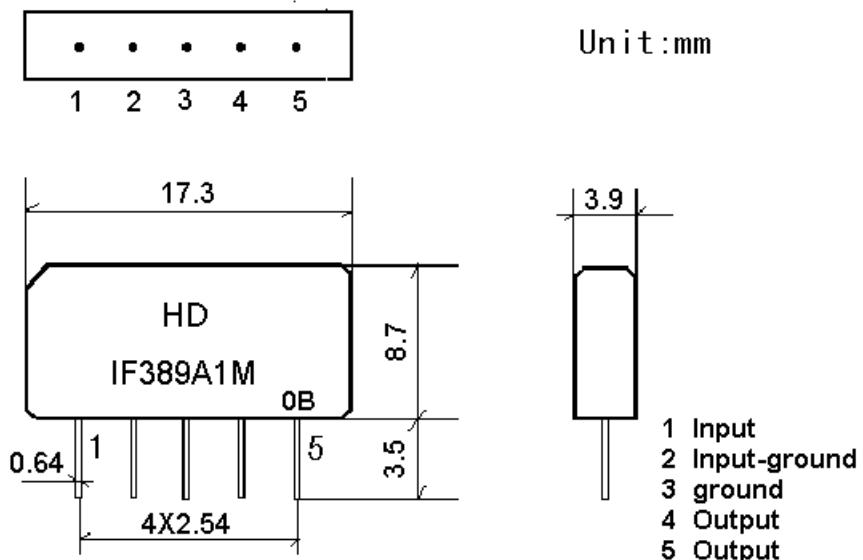
HAODA's SAW filter series have broad line up products meeting all broadcast standard including NTSC,PAL and SECAM systems. These filters are composed of two interdigital transducers on a single-crystal piezoelectrical chip. they are used in electronic equipments such as TV and so on.

## 2.Construction

### 2.1 Dimension and materials

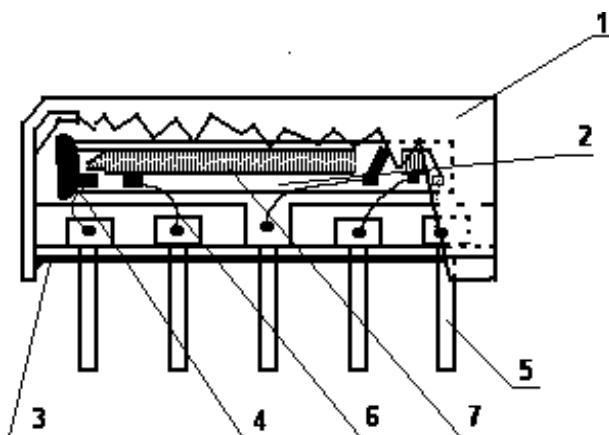
Manufacturer's name : HAODA ELECTRONICS Co. LTD(CHINA)

Type : IF389A1M



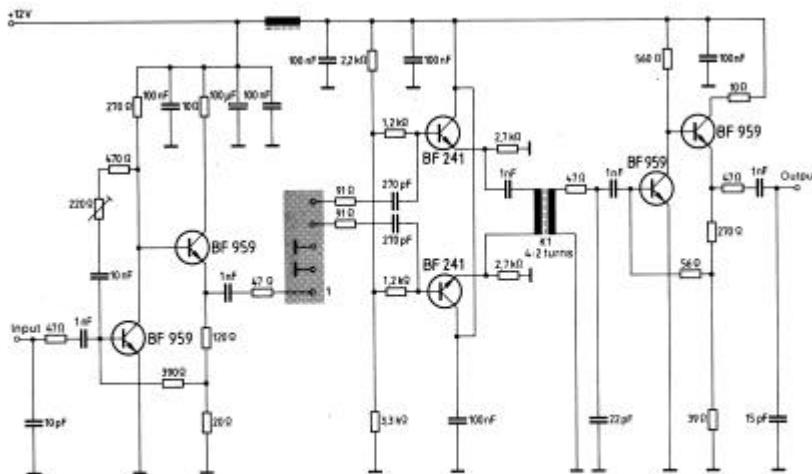
0: year(0,1,2,3,4,5,6,7,8,9)

B:product in this quarter(A:1~3,B:4~6,C:7~9,D:10~12)



Components	Materials
1. Outer casing	PPS
2. Substrate	Lithium niobate
3. Base	Epoxy resin
4. Absorber	Epoxy resin
5. Lead	Cu alloy+Au plate
6. Bonding wire	AlSi alloy
7. Electrode	Al

## 2.2. Circuit construction, measurement circuit



Test circuit for SIP-5 filter

Input impedance of the symmetrical post-amplifier: 2 k $\Omega$  in parallel with 3 pF

## 3.Characteristics

### Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests is as follows;

Ambient temperature : 15 to 35

Relative humidity : 25% to 85%

Air pressure : 86kPa to 106kPa

### Operating temperature rang

Operating temperature range is the range of ambient temperatures in which the filter can be

operated continuously. -10 ~ +60

### Storage temperature rang

Storage temperature range is the range of ambient temperatures at which the filter can be stored

without damage.

Conditions are as specified elsewhere in these specifications. -40 ~ +70

Reference temperature +25

### 3.1 Maximum Rating

<b>DC voltage</b>	<b>VDC</b>	<b>12</b>	<b>V</b>	<b>Between any terminals</b>
<b>AC voltage</b>	<b>Vpp</b>	<b>10</b>	<b>V</b>	<b>Between any terminals</b>

### 3.2 Electrical Characteristics

Source impedance  $Z_s=50$

Load impedance  $Z_L=2K \parallel 3pF$   $T_A=25$

		Freq	Min	typ	max	
<b>Insertion attenuation</b> Reference level		37.40MHz	13.5	15.5	17.5	dB
Relative attenuation	38.90MHz	5.5	6.5	7.5		dB
	34.47MHz	1.2	2.7	4.2		dB
	33.40MHz	17.0	19.0	21.0		dB
	31.90MHz	42.0	50.0	-		dB
	40.40MHz	42.0	55.0			dB
	41.40MHz	40.0	50.0			dB
<b>Sidelobe</b>	25.00~31.90MHz	34.0	40.0			dB
	40.40~45.00MHz	33.0	38.0			dB
Reflected wave signal suppression 1.2 $\mu$ s...6.0 $\mu$ s after main pulse (test pulse 250ns, carrier frequency 37.4MHz)		40.0	50.0			dB
Feedthrough signal suppression 1.2 $\mu$ s...1.1 $\mu$ s before main pulse (test pulse 250ns, carrier frequency 37.4MHz)		42.0	52.0	-		dB
Group delay predistortion (reference frequency 38.90 MHz) 36.90 MHz 34.47 MHz		-	-40	-	ns	
-	-	80	-	-	ns	
Impedance at 37.40 MHz: Input: $Z_{in} = R_{in} \parallel C_{in}$ Output $Z_{out}=R_{out} \parallel C_{out}$		-	2.6//9.5	-	$k \parallel pF$	
Temperature coefficient		-	2.9 //2.6	-	$k \parallel pF$	
		-72			ppm/k	

### 3.3 Environmental Performance Characteristics

Item Test condition	Allowable change of absolute Level at center frequency(dB)
High temperature test 70 1000H	< 1.0
Low temperature test -40 1000H	< 1.0
Humidity test 40 90-95% 1000H	< 1.0
Thermal shock -20 ==25 ==80 20 cycle 30M 10M 30M	< 1.0
Solder temperature test Sold temp.260 for 10 sec.	< 1.0

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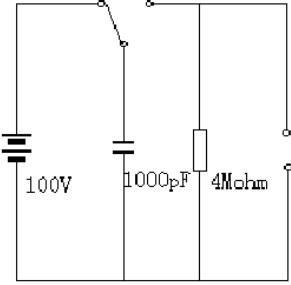
Soldering Immerse the pins melt solder at 260 +5/-0 for 5 sec.	More then 95% of total area of the pins should be covered with solder
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### 3.4 Mechanical Test

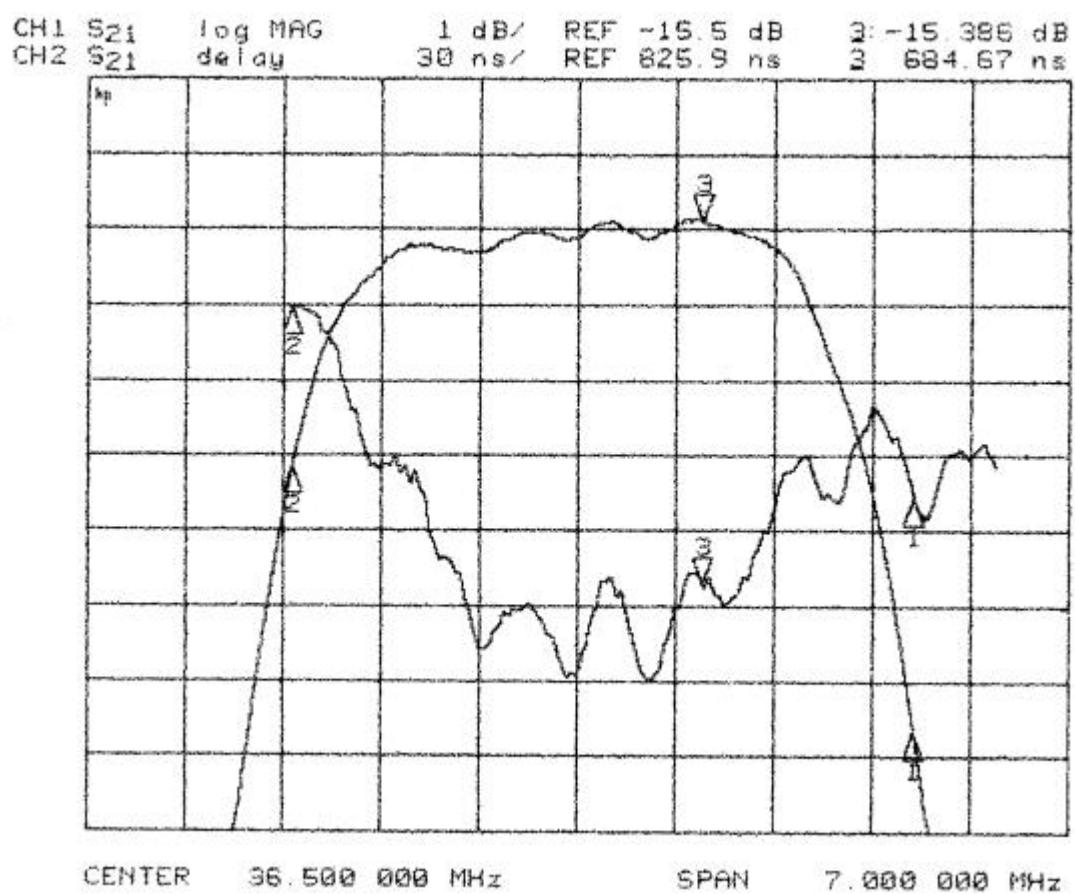
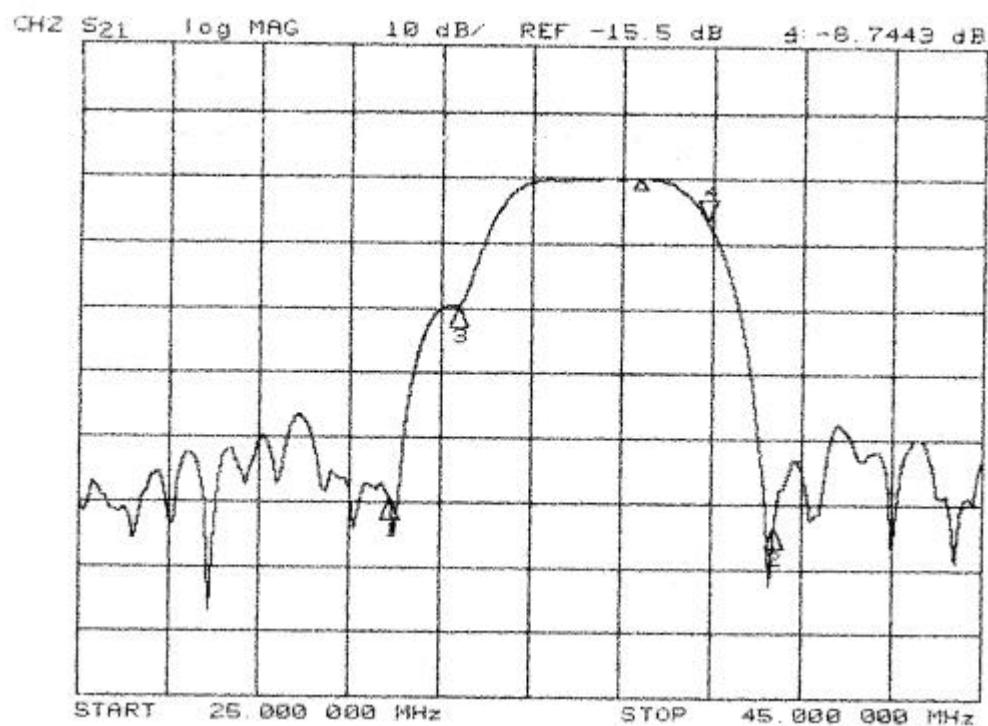
Item Test condition	Allowable change of absolute Level at center frequency(dB)
Vibration test 600-3300rpm amplitude 1.5mm 3 directions 2 H each	<1.0
Drop test On maple plate from 1 m high 3 times	<1.0
Lead pull test Pull with 1 kg force for 30 seconds	<1.0
Lead bend test 90° bending with 500g weigh 2 times	<1.0

### 3.5 Voltage Discharge Test

Item Test condition	Allowable change of absolute Level at center frequency(dB)
Surge test Between any two electrode	<1.0



### 3.6 Frequency response



CH2 521 Log MAG 10 dB/ REF -15.5 dB

